Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/006,999	FABER ET AL.	
Examiner	Art Unit	•
Yubin Huna	2625	

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382	162,166 167,244 248,250 276	11/29/2005	ΥH
345	644	11/29/2005	YH
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INT	INTERFERENCE SEARCHED		
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	DATE	EXMR
EAST Text search (US_PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB)	01/109/06	ΥН
IEEE Xplore	11/29/2005	ΥH
ACM	01/0920/06	ΥH
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